

ETR02033-002

Highly Accurate, Ultra Small, Low Power Consumption Voltage Detector

■GENERAL DESCRIPTION

The XC61J series is highly precise, low power consumption voltage detectors, manufactured using CMOS and laser trimming technologies. With low power consumption and high accuracy, the series is suitable for precision mobile equipment. The XC61J in ultra small package is ideally suited for high-density mounting. The XC61J is available in both CMOS and N-channel open drain output configurations.

APPLICATIONS

- Microprocessor reset circuitry
- Memory battery back-up circuits
- Power-on reset circuits
- Power failure detection
- System battery life and charge voltage monitors

■ FEATURES

Highly Accurate $\begin{array}{c} \pm 2\% \ (V_{DF} \geqq 1.5V) \\ \pm 30 \text{mV} \ (V_{DF} < 1.5V) \end{array}$

Low Power Consumption $0.6 \,\mu$ A [\dot{V}_{DF} =2.7V, \dot{V}_{IN} =2.97V]Detect Voltage Range $1.0 \,\text{V} \sim 5.0 \,\text{V}$ (0.1V increments)

Operating Voltage Range Detect Voltage: $0.7V \sim 6.0V$ Temperature Characteristics : ± 100 ppm/°C (TYP.) Output Configuration : CMOS (XC61JC)

N-channel open drain (XC61JN)

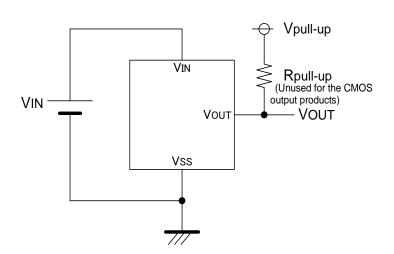
Operating Temperature Range $:-40^{\circ}\text{C} \sim +85^{\circ}\text{C}$ Package :SOT-25

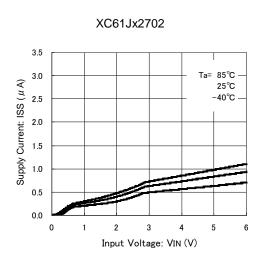
Environmentally Friendly : EU RoHS Compliant, Pb Free

■TYPICAL APPLICATION CIRCUIT

■ TYPICAL PERFORMANCE CHARACTERISTICS

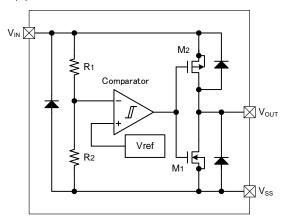
Supply Current vs. Input Voltage



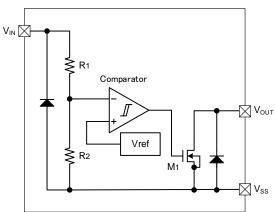


■BLOCK DIAGRAMS

(1) XC61JC







^{*} Diodes inside the circuits are ESD protection diodes and parasitic diodes.

■ PRODUCT CLASSIFICATION

Ordering Information

XC61J1234567-8 (*1)

DESIGNATOR	ITEM	SYMBOL	DESCRIPTION
1)	Output Configuration	С	CMOS output
	Output Configuration	N	N-ch open drain output
23	Detect Voltage	10~50	e.g. 1.0V → ②=1, ③=0
45	Detect Accuracy	02	$\pm 2\% (1.5V \le V_{DF} \le 5.0V)$
40	Detect Accuracy		± 30 mV (1.0V \leq V _{DF} $<$ 1.5V)
		MR-G	SOT-25(3,000pcs/Reel) (*3)
67-8	Package (Order Unit) Taping Specification ^(*2)	IVII C	Standard feed
		ML-G	SOT-25(3,000pcs/Reel) (*3)
		IVIL-G	Reverse feed

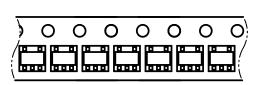
^(*1) The "-G" suffix denotes Halogen and Antimony free as well as being fully EU RoHS compliant.

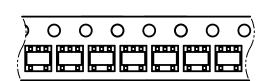
direction of feed

Taping Specification

• MR-G

· ML-G



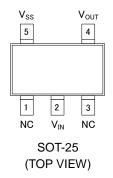


direction of feed

^(*2) Refer to the Taping Specification.

^(*3) SOT-25 uses Cu wires.

■ PIN CONFIGURATION



■ PIN ASSIGNMENT

PIN NUMBER	PIN NAME	FUNCTION		
SOT-25	PIN NAIVIE	FUNCTION		
1	NC	No Connection		
2	Vin	Power Input		
3	NC	No Connection		
4	Vout	Signal Output (Active Low)		
5	Vss	Ground		

■ ABSOLUTE MAXIMUM RATINGS

Ta=25°C

PARAMETER		SYMBOL	RATING	UNITS	
Input Voltage		V _{IN}	-0.3~+7.0	V	
Output Cur	Output Current		10	mA	
Output Voltage	XC61JC (*1)	V	-0.3~V _{IN} +0.3 or +7.0 ^(*3)	\/	
Output voitage	XC61JN (*2)	Vouт	-0.3~+7.0	V	
Dower Dissipation	SOT-25	D4	250	m\//	
Power Dissipation	501-25	Pd	600 (40mm x 40mm Standard board)(*4)	- mW	
Operating Temperature Range		Topr	-40~+85	°C	
Storage Temperat	ure Range	Tstg	-55~+125	°C	

^(*1) CMOS Output

^(*2) N-ch Open Drain Output

 $^{^{(\}ast 3)}$ The maximum value should be either $V_{\text{IN}}\text{+}0.3$ or +7.0 in the lowest

 $^{^{({}^*\!4)}}$ The power dissipation figure shown is PCB mounted and is for reference only. The mounting condition is please refer to PACKAGING INFORMATION.

■ELECTRICAL CHARACTERISTICS

XC61J Series Ta=25°C

PARAN	METER	SYMBOL		CONDITION	MIN.	TYP.	MAX.	UNITS	CIRCUIT
Operating	g Voltage	V _{IN}	V _{DF(T)} =1.0~5.0V (*1)		0.7	-	6.0	V	-
Detect	Voltage	V_{DF}		V _{DF(T)} =1.0V∼5.0V E-1		V	1		
Hysteres	sis Width	V _{HYS}		V _{DF(T)} =1.0V∼5.0V	V _{DF} × 0.03	V _{DF} × 0.05	V _{DF} × 0.07	V	1
Quiescent	Current 1	I _{SS1}		$V_{IN}=V_{DF(T)}\times 1.1$		E-2		μΑ	2
Quiescent	t Current 2	I _{SS2}		$V_{IN}=V_{DF(T)}\times 0.9$		E-3		μΑ	2
			.,	V _{OUT} =0.5V	0.09	0.57	-		
			V _{IN} =0.7	Vout=0.3V	0.08	0.56	-		
		V V _{IN=2} V V _{IN=3} V	V	V _{OUT} =0.1V	0.05	0.30	-		
			V _{IN} =1.0	V _{OUT} =0.1V, V _{DF(T)} >1.0V	0.46	0.71	-		
Output	Current		V _{IN} =2.0	V _{OUT} =0.1V, V _{DF(T)} >2.0V	1.15	1.41	-	mA	3
			V _{IN} =3.0	V _{OUT} =0.1V, V _{DF(T)} >3.0V	1.44	1.77	-		
			V _{IN} =4.0	V _{OUT} =0.1V, V _{DF(T)} >4.0V	1.61	1.96	-		
		I _{OUTP} (*2)	V _{IN} =6.0	Vout=5.5V	-	-0.95	-0.60	mA	3
Leakage	CMOS Output	I _{LEAK}	V_{IN}	$=V_{DF} \times 0.9V, V_{OUT} = 0V$	-	-0.001	1		
Current	N-ch Open Drain Output		V _{IN} =6.0V, V _{OUT} =6.0V		-	0.001	0.10	μΑ	3
Tempe Charac		$\Delta V_{DF}/$ ($\Delta Topr \cdot V_{DF}$)	-40 °C≦Topr≦85 °C		-	±100	-	ppm/°C	1
Detect Del	ay Time (*3)	t _{DF}	$V_{IN}=6.0V\rightarrow0.7V$ $V_{IN}=V_{DF}$ to $V_{OUT}=0.5V$		-	30	100	μs	4
Release De	elay Time (*5)	t _{DR}		V _{IN} =0.7V→6.0V =V _{DR} to V _{OUT} =V _{DR} (*4)	-	20	100	μs	4

^{*1:} V_{DF} (T): Nominal detect voltage

●XC61JN recommended pull-up resistance

Input Voltage Range	Pull-up Resistance			
0.7V~6.0V	≧ 220kΩ			
0.8V~6.0V	≧ 100kΩ			
1.0V~6.0V	≧ 33kΩ			

^{*2:} For XC61JC only.

^{*3:} A time taking from the time at $V_{IN} = V_{DF}$ to the time at V_{OUT} =0.5V when V_{IN} falls from 6.0V to 0.7V.

^{*4:} V_{DR}: Release voltage (V_{DR} = V_{DF} + V_{HYS})

^{*5:} A time taking from the time at $V_{IN} = V_{DR}$ to the time at $V_{OUT} = V_{DR}$ when V_{IN} rise from 0.7V to 6.0V.

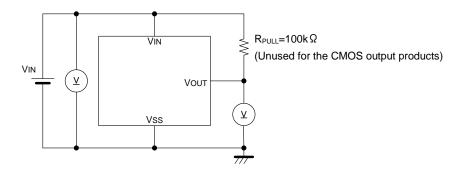
■ ELECTRICAL CHARACTERISTICS (Continued)

• DETECT VOLTAGE ACCURACY AND QUIESCENT CURRENT SPECIFICATIONS

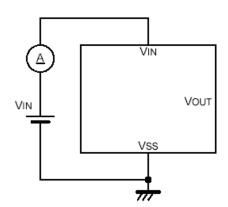
SYMBOL	E-1		E	-2	E-3		
NOMINAL DETECT VOLTAGE	DETECT VOLTAGE (V)			QUIESCENT CURRENT1 (μA)		QUIESCENT CURRENT2 (μ A)	
	V	OF	Is	S1	Is	S2	
$V_{DF(T)}$	MIN.	MAX.	TYP.	MAX.	TYP.	MAX.	
1.0	0.970	1.030					
1.1	1.070	1.130					
1.2	1.170	1.230					
1.3	1.270	1.330					
1.4	1.370	1.430	0.5	1.4	0.4	1.35	
1.5	1.470	1.530	0.5	1.4	0.4	1.55	
1.6	1.568	1.632					
1.7	1.666	1.734					
1.8	1.764	1.836					
1.9	1.862	1.938					
2.0	1.960	2.040			0.5	1.60	
2.1	2.058	2.142					
2.2	2.156	2.244		1.7			
2.3	2.254	2.346	0.0				
2.4	2.352	2.448	0.6				
2.5	2.450	2.550					
2.6	2.548	2.652					
2.7	2.646	2.754					
2.8	2.744	2.856					
2.9	2.842	2.958					
3.0	2.940	3.060					
3.1	3.038	3.162					
3.2	3.136	3.264					
3.3	3.234	3.366					
3.4	3.332	3.468					
3.5	3.430	3.570	1				
3.6	3.528	3.672	1				
3.7	3.626	3.774	1				
3.8	3.724	3.876	1			1.80	
3.9	3.822	3.978	0.7	1.9	0.6		
4.0	3.920	4.080	1				
4.1	4.018	4.182	1				
4.2	4.116	4.284	1				
4.3	4.214	4.386	1				
4.4	4.312	4.488	1				
4.5	4.410	4.590	1				
4.6	4.508	4.692	1				
4.7	4.606	4.794	1				
4.8	4.704	4.896	1				
4.9	4.802	4.998	1				
5.0	4.900						

■TEST CIRCUITS

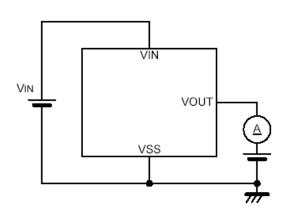
Circuit ①



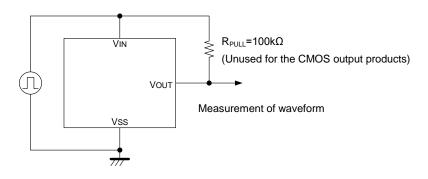
Circuit ②



Circuit ③

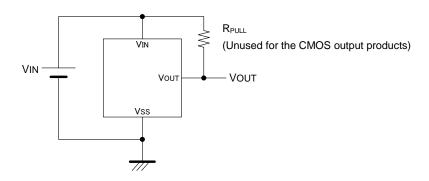


Circuit 4

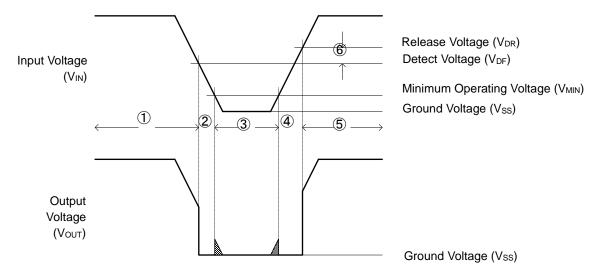


■OPERATIONAL EXPLANATION

Typical Application Circuit



Timing Chart



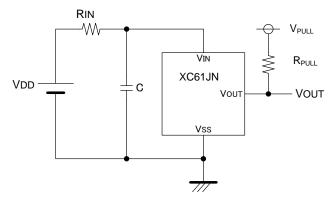
Note: The above timing chart omits the t_{DF} and t_{DR} .

The following explains the operation of the typical application circuit along number symbols shown in the timing chart.

- When input voltage (V_{IN}) is higher than detect voltage (V_{DF}), output voltage (V_{OUT}) will be equal to input voltage (V_{IN}).
 (A condition of high impedance exists with N-ch open drain output configurations.)
- When input voltage (V_{IN}) falls below detect voltage (V_{DF}), output voltage (V_{OUT}) will be equal to the ground voltage (V_{SS}) level.
- ③ When input voltage (V_{IN}) falls to a level below that of the minimum operating voltage (V_{MIN}), output will become unstable. If In this condition, V_{IN} will equal the pulled-up output (should output be pulled-up.) (Input voltage, V_{IN}, in the typical application circuit.)
- 4 When input voltage (V_{IN}) rises above the minimum operating voltage (V_{MIN}) level until it achieves a release voltage (V_{DR}) , output keeps the ground voltage level (V_{SS}) .
- \bigcirc When the input voltage (V_{IN}) rises above the release voltage (V_{DR}) , output voltage $(V_{OUT}$ will be equal to input voltage (V_{IN}) . (A condition of high impedance exists with N-ch open drain output configurations.)
- 6 The difference between V_{DR} and V_{DF} represents the hysteresis width.

■NOTE ON USE

- 1. Please use this IC within the stated maximum ratings. For temporary, transitional voltage drop or voltage rising phenomenon, the IC is liable to malfunction should the ratings be exceeded.
- 2. In order to stabilize the IC's operations, please ensure that V_{IN} pin's input frequency's rise and fall times are more than several μ s / V.
- 3. With a resistor connected between the V_{IN} pin and the power supply V_{DD} some errors may be observed from the input voltage at the detect and release voltage. Those errors are not constant because of the fluctuation of the supply current.
- 4. When a resistor is connected between the V_{IN} pin and the power supply V_{DD}, oscillation may occur as a result of through current and voltage drop at the R_{IN} at the time of voltage release. (refer to the Oscillation Description (1) below) Especially in the CMOS output configurations, oscillation may occur regardless of detect/release operation if load current (I_{OUT}) exists. (refer to the Oscillation Description (2) below)
- 5. Please use N-ch open drains configuration, when a resistor R_{IN} is connected between the V_{IN} pin and the power supply V_{DD} power source. In such cases, please ensure that R_{IN} is less than $10k\Omega$ and that C is more than 0.1μ F.
- Torex places an importance on improving our products and its reliability.
 However, by any possibility, we would request user fail-safe design and post-aging treatment on system or equipment.



[Figure 1: Circuit connected with the input resistor]

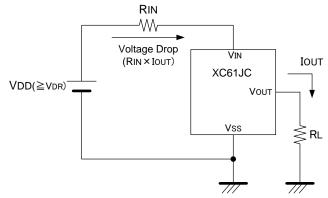
Oscillation Description

(1) Oscillation as a result of through current

Since the XC61J series are CMOS ICs, transient through current will flow when the IC's internal circuit switching operates regardless of output configuration. Consequently, oscillation is liable to occur as a result of the similar operations as in (1) above. This oscillation does not occur during the detect operation.

(2) Output current oscillation with the CMOS output configuration

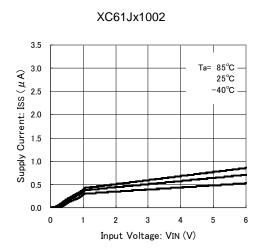
As shown in figure 2, when the voltage applied at the power supply (V_{DD}) rises from below detect voltage to above release voltage, the IC commence release operations and the internal P-ch driver transistor will be on. The output current (I_{OUT}) flows the input resistor (R_{IN}) via the P-ch driver transistor. Because of the input resistor (R_{IN}) and the output current (I_{OUT}) , an input pin voltage drops $R_{IN} \times I_{OUT}$. If the voltage drop level is larger than the IC's hysteresis width (V_{HYS}) , the input pin voltage will falls below the V_{DF} and detect operations will commerce so that the internal P-ch driver transistor will be off. The voltage drop will stop because the output current (I_{OUT}) which was flowing the P-ch driver transistor will run down. The input pin voltage will become the same voltage level as the input voltage (V_{IN}) . For this, the input pin voltage will rise above the release voltage (V_{DR}) , therefore, the release operations will begin over again. Oscillation may occur with this repetition. Further, this condition will also appear via means of a similar mechanism during detect operations.

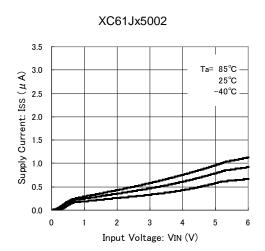


[Figure 2: Oscillation caused by the input resistor of the CMOS output product and the output current]

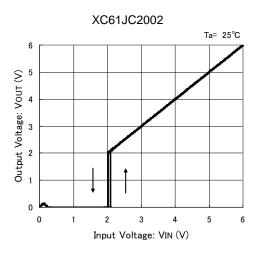
■TYPICAL PERFORMANCE CHARACTERISTICS

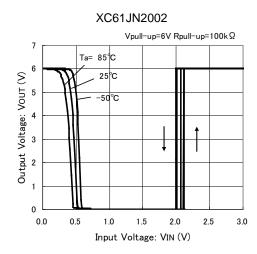
(1) Supply Current vs. Input Voltage



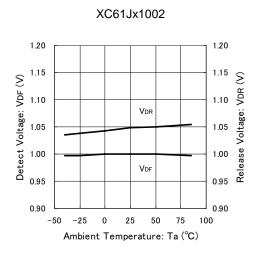


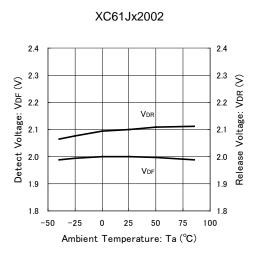
(2) Output Voltage vs. Input Voltage





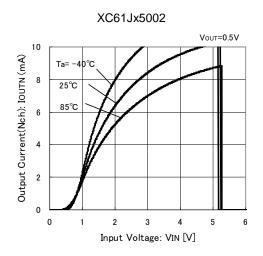
(3) Detect Voltage, Release Voltage vs. Ambient Temperature

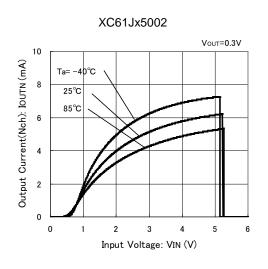




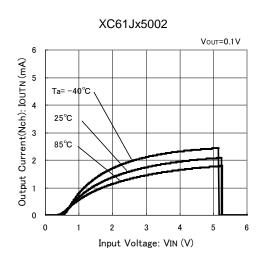
■TYPICAL PERFORMANCE CHARACTERISTICS (Continued)

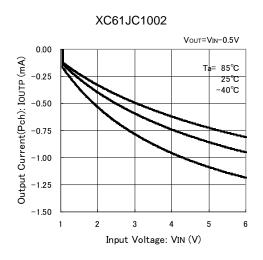
(4) Output Current (Nch Driver) vs. Input Voltage

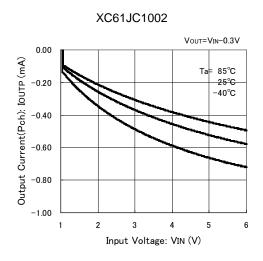


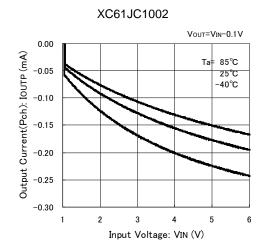


(5) Output Current (Pch Driver) vs. Input Voltage









■ PACKAGING INFORMATION

For the latest package information go to, www.torexsemi.com/technical-support/packages

PACKAGE	OUTLINE / LAND PATTERN	THERMAL CHARACTERISTICS		
SOT-25	SOT-25 PKG	Standard Board	SOT-25 Power Dissipation	

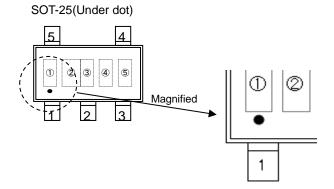
■MARKING RULE

●SOT-25

① represents product series

MARK	PRODUCT SERIES			
Н	XC61J*****-G			

^{*} SOT-25 with the under-dot marking is used.



2 represents output configuration

MARK	DESCRIPTION	DETECT VOLTAGE RANGE (V)	PRODUCT SERIES	
С	CMOS output	1.0~3.9 XC61JC******		
D	CMOS output	4.0~5.0		
N	N ob open drain output	1.0~3.9	VC61 INI***** C	
Р	N-ch open drain output 4.0~5.0		XC61JN*****-G	

3 represents detect voltage

MARK	VOLTAGE (V)						
0	1.0	Α	2.0	N	3.0	0	4.0
1	1.1	В	2.1	Р	3.1	1	4.1
2	1.2	С	2.2	R	3.2	2	4.2
3	1.3	D	2.3	S	3.3	3	4.3
4	1.4	E	2.4	Т	3.4	4	4.4
5	1.5	F	2.5	U	3.5	5	4.5
6	1.6	Н	2.6	V	3.6	6	4.6
7	1.7	Ν	2.7	Х	3.7	7	4.7
8	1.8	L	2.8	Υ	3.8	8	4.8
9	1.9	М	2.9	Z	3.9	9	4.9
'-						Α	5.0

45 represents production lot number. 01 ~ 09, 0A ~ 0Z, 11 ~ 9Z, A1 ~ A9, AA \sim AZ $_{\sim}$ B1 \sim ZZ repeated.

(G, I, J, O, Q, W excluded.)

* No character inversion used.

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